

<b>Notice of References Cited</b>	Application/Control No. 10/760,587	Applicant(s)/Patent Under Reexamination KITAMURA ET AL.	
	Examiner Meghan K. Dunwiddie	Art Unit 2875	Page 1 of 1

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*	B	US-2004/0130880	07-2004	Min et al.	362/031
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